



2814

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re PATENT APPLICATION of

Kyoung-Yoon Baek et al.

Group Art Unit: 2814

Serial No.: 10/043,329

Examiner: Rao, Shrinivas H.

Filed: 14 January 2002

For: OVERLAY KEY, METHOD OF
MANUFACTURING THE SAME AND
METHOD OF MEASURING AN
OVERLAY DEGREE USING THE
SAME

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RESPONSE TO ELECTION/RESTRICTION REQUIREMENT

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Crystal Plaza Two, Lobby, Room 1B03
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Sir:

In response to the Office Action of 29 September 2003, Applicants elect the invention of Group I, Claims 1-24, drawn to an overlay key. The election is without traverse.

Respectfully submitted,

VOLENTINE FRANCOS, PLLC

Kenneth D. Springer
Registration No. 39,843

12200 Sunrise Valley Drive, Suite 150
Reston, Virginia 20191
Telephone No.: (703) 715-0870
Facsimile No.: (703) 715-0877

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